

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
263148US90PCTSERIAL NO.
10/518,020

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Yutaka YOSHIDAFILING DATE
December 15, 2004

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
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	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	2004/111398	12/23/04	WO (with English abstract)		NO
	AP	2005/000445	01/06/05	WO (with English abstract)		NO
	AQ	2004/113252	12/29/04	WO (with English abstract)		NO
	AR	2005/002709	01/13/05	WO (with English abstract)		NO
	AS	2005/005018	01/20/05	WO (with English abstract)		NO
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
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☐ Additional References sheet(s) attached

Examiner

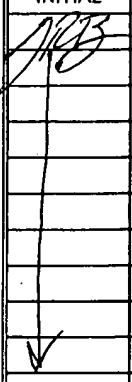
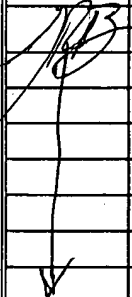
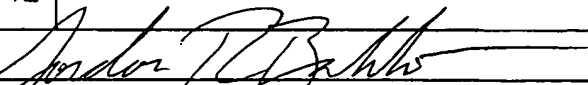
Date Considered

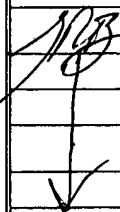
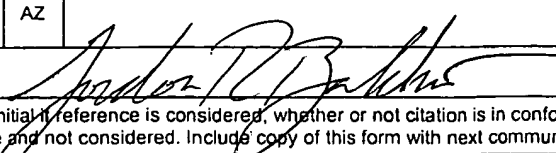
3/31/2007

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10/518020

DT05 Rec'd PCT/P... DEC 2004 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 263148US90PCT		SERIAL NO. New U.S. PCT Application Based on PCT/JP03/12842	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yutaka YOSHIDA			
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5 914 187	06/22/99	NARUSE et al.			
	AB	2004-0031264	02/19/04	KOJIMA			
	AC	5 930 994	08/03/99	SHIMATO et al.			
	AD	6 447 564	09/10/02	OHNO et al.			
	AE	6 565 630	05/20/03	OHNO et al.			
	AF	6 669 751	12/30/03	OHNO et al.			
	AG	2004-0055265	03/25/04	OHNO et al.			
	AH	2004-0033175	02/19/04	OHNO et al.			
	AI	6 770 116	08/03/04	KOJIMA			
	AJ	2004-0223892	11/11/04	KOJIMA			
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AN	01 93984	12/13/01	WO (with English abstract & equivalent of US 2003/53940)		NO	
	AO	02 076579	10/03/02	WO (with English abstract)		NO	
	AP	06-182228	07/05/94	JP (with English abstract)		NO	
	AQ	2001-199777	07/24/01	JP (with English abstract)		NO	
	AR	2002-060279	02/26/02	JP (with English abstract)		NO	
	AS	2002-154876	05/28/02	JP (with English abstract)		NO	
	AT	2004-076027	09/10/04	WO (with English abstract)		NO	
	AU	2004-106702	12/09/04	WO (with English abstract)		NO	
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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Examiner 					<input type="checkbox"/> Additional References sheet(s) attached Date Considered <u>3/31/2007</u>		
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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 263148US40PCT		SERIAL NO. 10/518,020	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yutaka YOSHIDA			
				FILING DATE December 15, 2004		GROUP 1775	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	2002-201082	07/16/2002	JAPAN (with English Abstract and corr. EP 1 277 714 A1)		X	
	AP	1 277 714 A1	01/22/2003	EUROPE			
	AQ	1 340 734 A1	09/03/2003	EUROPE			
	AR	5-17227	01/26/1993	JAPAN (with English Abstract and English translation)	X		
	AS	WO 2005/044425 A1	05/19/2005	WIPO (with English Abstract)		X	
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	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Derwent Publications, AN 1993-070915, XP-002370065, JP 5-17227, January 26, 1993					
	AX						
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	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner 					Date Considered <u>3/31/2007</u>		
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>MB</i>	AA	2002/0011683 A1	01/31/2002	Kishor P. GADKAREE, et al.			
	AB						
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	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>Jonathan R. B. [Signature]</i>					Date Considered <i>3/31/2007</i>		
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